### **ANALOG DEVICES** Dual 0.275% Comparators and Reference with Programmable Hysteresis

### **FEATURES**

400 mV ± 0.275% threshold User programmable hysteresis via resistor string Supply range: 1.7 V to 5.5 V Low quiescent current: 6.5 μA typical Input range includes ground Low input bias current: ±5 nA maximum Open-drain outputs Supports wired-AND connections Input polarities: ADCMP341 noninverting ADCMP343 inverting Small SOT-23 package

#### **APPLICATIONS**

Portable applications Li-lon monitoring Handheld instruments LED/relay driving Optoisolator driving Control systems

### **GENERAL DESCRIPTION**

The ADCMP341/ADCMP343 consist of two low power, high accuracy comparators with a 400 mV reference in an 8-lead SOT-23 package. Operating within a supply range of 1.7 V to 5.5 V, the devices only draw 6.5  $\mu$ A (typical), making them ideal for low voltage system monitoring and portable applications.

Hysteresis is determined using three resistors in a string configuration with the upper and lower tap points connected to the  $\pm$ INA\_U and  $\pm$ INA\_L pins of each comparator, respectively. The state of the outputs of the comparators selects which pin is internally connected to the comparators input. Therefore, a change of state in the comparators output results in one of the inputs being switched in to the comparator and the other being switched out. This provides the user with a fully flexible and accurate method of setting the hysteresis. One input of each comparator is internally connected to the reference. The other input is available externally, via an internal mux, through pins  $\pm$ INA\_U or  $\pm$ INA\_L. The state of the output determines which of these pins is connected at any one time.

The comparator outputs are open-drain with the output stage sinking capability guaranteed greater than 5 mA over temperature. The ADCMP341 has noninverting inputs and the ADCMP343 has inverting inputs. The devices are suitable for portable, commercial, industrial, and automotive applications.

#### Rev. 0

Information furnished by Analog Devices is believed to be accurate and reliable. However, no responsibility is assumed by Analog Devices for its use, nor for any infringements of patents or other rights of third parties that may result from its use. Specifications subject to change without notice. No license is granted by implication or otherwise under any patent or patent rights of Analog Devices. Trademarks and registered trademarks are the property of their respective owners.

# ADCMP341/ADCMP343

### FUNCTIONAL BLOCK DIAGRAMS

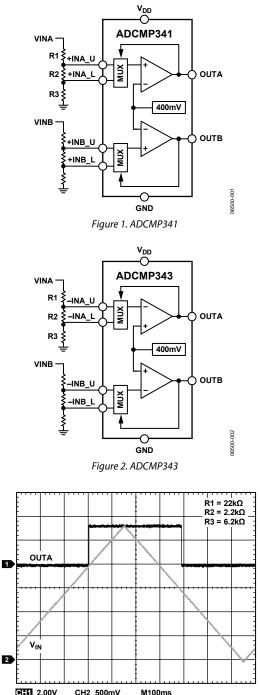


Figure 3. Hysteresis programmed to 513 mV @ V<sub>IN</sub> on ADCMP341

 One Technology Way, P.O. Box 9106, Norwood, MA 02062-9106, U.S.A.

 Tel: 781.329.4700
 www.analog.com

 Fax: 781.461.3113
 ©2007 Analog Devices, Inc. All rights reserved.

## **TABLE OF CONTENTS**

Features 1
Applications1
General Description
Functional Block Diagrams1
Revision History
Specifications
Absolute Maximum Ratings 4
Thermal Characteristics
ESD Caution
Pin Configurations and Function Descriptions

## 

### **REVISION HISTORY**

2/07—Revision 0: Initial Version

## **SPECIFICATIONS**

 $V_{\rm DD}$  = 1.7 V to 5.5 V,  $-40^{\circ}C \leq T_{\rm A} \leq +125^{\circ}C$  , unless otherwise noted.

Table 1.

Parameter	Min	Тур	Мах	Unit	<b>Test Conditions/Comments</b>
THRESHOLD <sup>1</sup>					
Threshold Voltage	396.6	400.4	404.3	mV	$V_{DD} = 1.7 V, T_A = 25^{\circ}C$
	399.3	400.4	401.5	mV	$V_{DD} = 3.3 V, T_A = 25^{\circ}C$
	398.5	400.4	402.2	mV	$V_{DD} = 5.5 V, T_A = 25^{\circ}C$
	395.0	400.4	405.8	mV	$V_{DD} = 1.7 \text{ V}, 0^{\circ}\text{C} \le T_{A} \le 70^{\circ}\text{C}$
	397.4	400.4	403.4	mV	$V_{\text{DD}}=3.3~V,~0^{\circ}C\leq T_{\text{A}}\leq70^{\circ}C$
	396.9	400.4	403.7	mV	$V_{DD} = 5.5 \text{ V}, 0^{\circ}\text{C} \le T_A \le 70^{\circ}\text{C}$
	391.2	400.4	407.7	mV	$V_{DD} = 1.7 \text{ V}, -40^{\circ}\text{C} \le T_{A} \le +125^{\circ}\text{C}$
	393.4	400.4	405.6	mV	$V_{DD} = 3.3 \text{ V}, -40^{\circ}\text{C} \le T_A \le +125^{\circ}\text{C}$
	393.2	400.4	405.8	mV	$V_{DD} = 5.5 \text{ V}, -40^{\circ}\text{C} \le T_A \le +125^{\circ}\text{C}$
Threshold Voltage Accuracy			±0.275	%	$T_A = 25^{\circ}C, V_{DD} = 3.3 V$
Threshold Voltage Temperature Coefficient		16		ppm/°C	
POWER SUPPLY					
Supply Current		6.5	9	μA	$V_{DD} = 1.7 V$
		7.0	10	μA	$V_{DD} = 5.5 V$
INPUT CHARACTERISTICS					
Input Bias Current		0.01	5	nA	$V_{DD} = 1.7 \text{ V}, V_{IN} = V_{DD}$
		0.01	5	nA	$V_{DD} = 1.7 \text{ V}, V_{IN} = 0.1 \text{ V}$
OPEN-DRAIN OUTPUTS					
Output Low Voltage <sup>2</sup>		140	220	mV	V <sub>DD</sub> = 1.7 V, I <sub>OUT</sub> = 3 mA
		140	220	mV	$V_{DD} = 5.5 \text{ V}, I_{OUT} = 5 \text{ mA}$
Output Leakage Current <sup>3</sup>		0.01	1	μA	$V_{DD} = 1.7 V$ , $V_{OUT} = V_{DD}$
		0.01	1	μA	$V_{DD} = 1.7 V$ , $V_{OUT} = 5.5 V$
DYNAMIC PERFORMANCE <sup>2, 4</sup>					
High-to-Low Propagation Delay		10		μs	$V_{DD} = 5 V, V_{OL} = 400 mV$
Low-to-High Propagation Delay		8		μs	$V_{\text{DD}} = 5 \text{ V}, V_{\text{OH}} = 0.9 \times V_{\text{DD}}$
Output Rise Time		0.5		μs	$V_{\text{DD}}$ = 5 V, $V_{\text{O}}$ = (0.1 to 0.9) $\times$ $V_{\text{DD}}$
Output Fall Time		0.07		μs	$V_{DD} = 5 V, V_{O} = (0.1 \text{ to } 0.9) \times V_{DD}$

 $\label{eq:constraint} \begin{array}{l} ^{1} R_{L} = 100 \ k\Omega, \ V_{O} = 2 \ V \ swing. \\ ^{2} \ 10 \ mV \ input \ overdrive. \\ ^{3} \ V_{IN} = 40 \ mV \ overdrive. \\ ^{4} \ R_{L} = 10 \ k\Omega. \end{array}$ 

## **ABSOLUTE MAXIMUM RATINGS**

### Table 2.

Parameter	Rating
V <sub>DD</sub>	–0.3 V to +6 V
±INA_U, ±INA_L, ±INB_U, ±INB_L	–0.3 V to +6 V
OUTA, OUTB	–0.3 V to +6 V
Operating Temperature Range	-40°C to +125°C
Storage Temperature Range	-65°C to +150°C
Lead Temperature	
Soldering (10 sec)	300°C
Vapor Phase (60 sec)	215°C
Infrared (15 sec)	220°C

Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

### THERMAL CHARACTERISTICS

 $\theta_{JA}$  is specified for the worst-case conditions, that is, a device soldered in a circuit board for surface-mount packages.

### Table 3. Thermal Resistance

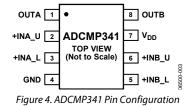
Package Type	Αιθ	Unit
8-Lead SOT-23	211.5	°C/W

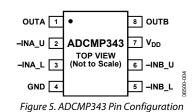
### **ESD CAUTION**



**ESD** (electrostatic discharge) sensitive device. Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

## **PIN CONFIGURATIONS AND FUNCTION DESCRIPTIONS**





## Table 4. Pin Function Descriptions

Table 4. Fin Function Descriptions				
Pin No.	Mnemonic	Description		
1	OUTA	Open-Drain Output for Comparator A.		
2	±INA_U	Monitors Analog Input Voltage on Comparator A. Connect to the upper tap point of the resistor string. Connect internally to the noninverting input on the ADCMP341 or the inverting pin on the ADCMP343 via a mux controlled by the output level on Comparator A. The other input of Comparator A is connected to a 400 mV reference.		
3	±INA_L	Monitors Analog Input Voltage on Comparator A. Connect to the lower tap point of the resistor string. Connect internally to the noninverting input on the ADCMP341 or the inverting pin on the ADCMP343 via a mux controlled by the output level on Comparator A. The other input of Comparator A is connected to a 400 mV reference.		
4	GND	Ground.		
5	±INB_L	Monitors Analog Input Voltage on Comparator B. Connect to the lower tap point of the resistor string. Connect internally to the noninverting input on the ADCMP341 or the inverting pin on the ADCMP343 via a mux controlled by the output level on Comparator B. The other input of Comparator B is connected to a 400 mV reference.		
6	±INB_U	Monitors Analog Input Voltage on Comparator B. Connect to the upper tap point of the resistor string. Connect internally to the noninverting input on the ADCMP341 or the inverting pin on the ADCMP343 via a mux controlled by the output level on Comparator B. The other input of Comparator B is connected to a 400 mV reference.		
7	V <sub>DD</sub>	Power Supply Pin.		
8	OUTB	Open-Drain Output for Comparator B.		

## **TYPICAL PERFORMANCE CHARACTERISTICS**

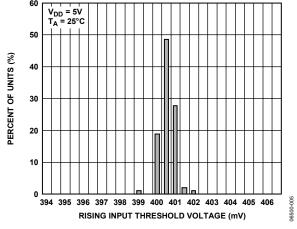


Figure 6. Distribution of Rising Input Threshold Voltage

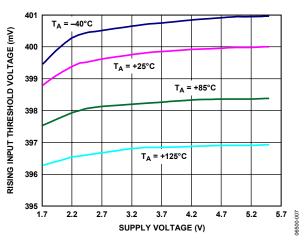


Figure 7. Rising Input Threshold Voltage vs. Supply Voltage

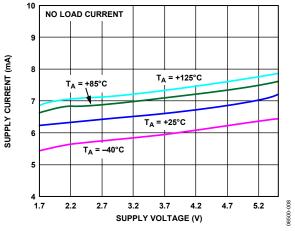


Figure 8. Quiescent Supply Current vs. Supply Voltage

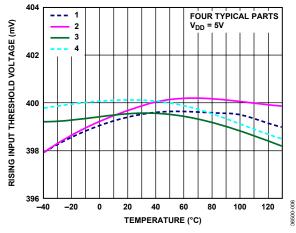


Figure 9. Rising Input Threshold Voltage vs. Temperature

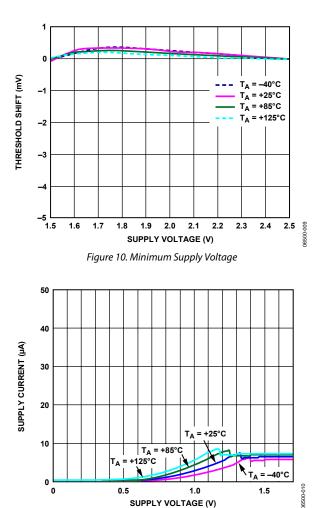
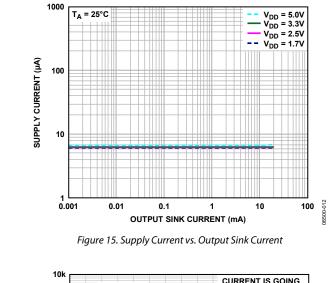
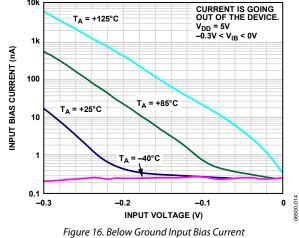
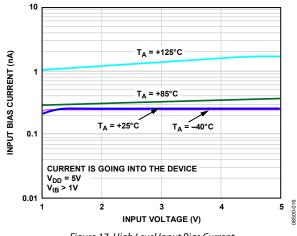
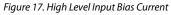


Figure 11. Start-Up Supply Current









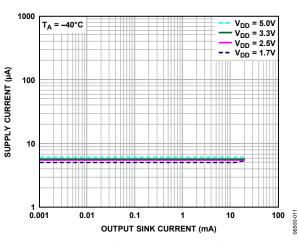
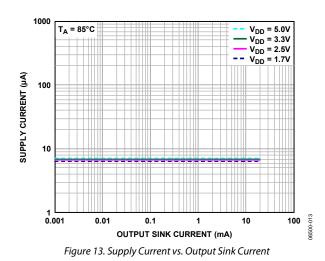


Figure 12. Supply Current vs. Output Sink Current



3 1 INPUT BIAS CURRENT (nA) T<sub>A</sub> = +125°C T<sub>A</sub> = +85°C -1 T<sub>A</sub> = +25°C T<sub>A</sub> = -40°C -3 CURRENT IS POSITIVE GOING INTO THE DEVICE. -5 V<sub>DD</sub> = 5V 0V < V<sub>IB</sub> < 1V -7 0 0.2 0.4 0.6 1.0 06500-015 0.8 INPUT VOLTAGE (V) Figure 14. Low Level Input Bias Current

Rev. 0 | Page 7 of 12

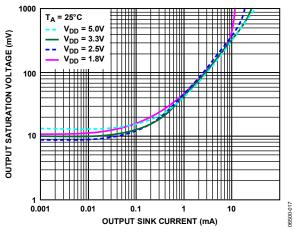


Figure 18. Output Saturation Voltage vs. Output Sink Current

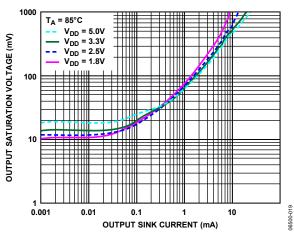


Figure 19. Output Saturation Voltage vs. Output Sink Current

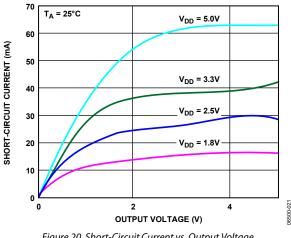


Figure 20. Short-Circuit Current vs. Output Voltage

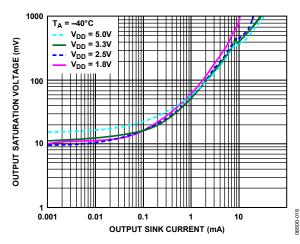
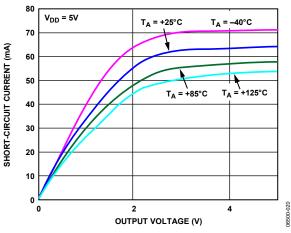
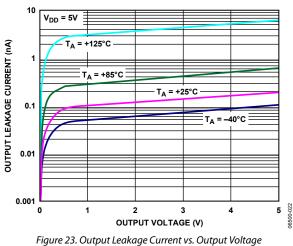


Figure 21. Output Saturation Voltage vs. Output Sink Current







100

06500-025

1000

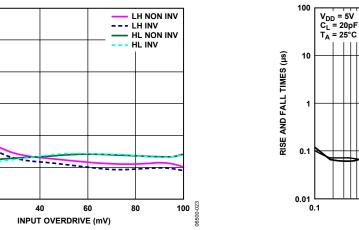


Figure 24. Propagation Delay vs. Input Overdrive

60

50

40

30

20

10

0

0

20

PROPAGATION DELAY (µs)

T<sub>A</sub> = 25°C

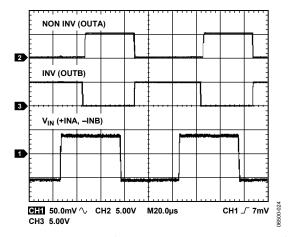


Figure 25. Noninverting and Inverting Comparators Propagation Delay



1

RISE

FALL

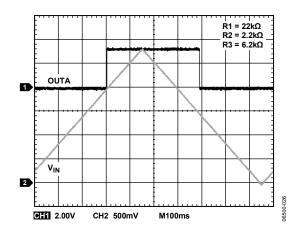


Figure 27. Hysteresis Programmed to ~513 mV at Top of Input String (Hysteresis at ADCMP341 Pins ≈ 104 mV)

## **APPLICATION INFORMATION**

The ADCMP341/ADCMP343 are dual, low power comparators with a built-in 400 mV reference that operates from 1.7 V to 5.5 V. The comparators are 0.275% accurate with fully programmable hysteresis, implemented using a new technique of a three-resistor string on the input. These open-drain outputs are capable of sinking up to 40 mA.

### **COMPARATORS AND INTERNAL REFERENCE**

Each of the comparators has one input available externally; the other comparator inputs are connected internally to the 400 mV reference. The ADCMP341 has two noninverting comparators and the ADCMP343 has two inverting comparators.

There are two input pins available to each comparator. However, these two input pins (±INx\_U, ±INx\_L) connect to the same input leg of the comparator via a muxing system. This is to provide fully programmable rising and falling trip points. The output of the comparator determines which pin is connected to the input of the same comparator. Using Figure 28 as an example, when OUTA is high, +INA\_U is connected to the comparator input. When the input voltage drops and passes below the 400 mV reference, the output goes low. This in turn disconnects +INA\_U from the comparator and connects +INA\_L. This leg of the string is at a lower voltage and thus instantaneously the effect of hysteresis is applied. Therefore, using a resistor string on the input as shown in Figure 28, the voltages for the rising and falling trip points can be programmed by selecting the appropriate resistors in the string.

### **POWER SUPPLY**

The ADCMP341/ADCMP343 are designed to operate from 1.7 V to 5.5 V. A 0.1  $\mu F$  decoupling capacitor is recommended between  $V_{\rm DD}$  and GND.

### INPUTS

The comparator inputs are limited to the maximum  $V_{\rm DD}$  voltage range. The voltage on these inputs can be above  $V_{\rm DD}$  but never above the maximum allowed  $V_{\rm DD}$  voltage.

### OUTPUTS

The open-drain comparator outputs are limited to the maximum specified  $V_{DD}$  voltage range, regardless of the  $V_{DD}$  voltage. These outputs are capable of sinking up to 40 mA. Outputs can be tied together to provide a common output signal.

### **PROGRAMMING HYSTERESIS**

When choosing the resistor values, the input bias current must be considered as a potential source of error. Begin by choosing a resistor value for R3, which takes into account the acceptable error introduced by the maximum specified input bias current. To reduce this error, the current flowing through the Resistor R3 should be considerably greater than the input bias current.

$$I_{R3} >> I_{BIAS}$$

R3 is therefore

$$R3 = \frac{V_{REF}}{I_{R3}}$$

Now R2 can be calculated from the following:

$$R2 = \frac{R_3 \left( V_{RISING} - V_{FALLING} \right)}{V_{FALLING}}$$

R1 can then be calculated using the following equation:

$$R1 = \left(R3 \times \left(\frac{V_{RISING}}{V_{REF}} - 1\right)\right) - R2$$

where:

 $V_{REF}$  is the specified on chip reference.

 $I_{BIAS}$  is the maximum specified input bias current.

*R1*, *R2*, and *R3* are the three resistors as shown in Figure 28.  $I_{R3}$  is the current flowing through *R3*.

 $V_{FALLING}$  is the desired falling trip voltage and lower of the two.  $V_{RISING}$  is the desired rising trip voltage and higher of the two.

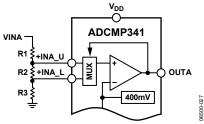


Figure 28. Programming Hysteresis Example

### LAYOUT RECOMMENDATIONS

Correct layout is very important to increase noise immunity. Long tracks from the input resistors to the device can lead to noise being coupled onto the inputs. To avoid this, it is best to place the input resistors as close as possible to the device. It is also recommended that a GND plane is used under this layout. The combination of small hysteresis and the use of a large R3 resistor further increases susceptibility to noise. In this case, a decoupling capacitor (CA, CB) may be required on the ±INx\_U node to help reduce any noise. A recommended layout example can be seen in Figure 29.

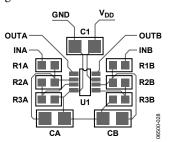
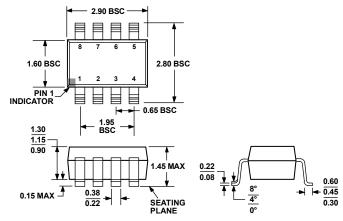


Figure 29. Recommended Layout Example

## **OUTLINE DIMENSIONS**



COMPLIANT TO JEDEC STANDARDS MO-178-BA Figure 30. 8-Lead Small Outline Transistor Package [SOT-23] (RJ-8) Dimensions shown in millimeters

### **ORDERING GUIDE**

Model Temperature Range		Package Description	Package Option	Branding
ADCMP341YRJZ-REEL71	-40°C to +125°C	8-Lead SOT-23	RJ-8	M8Y
ADCMP343YRJZ-REEL7 <sup>1</sup>	–40°C to +125°C	8-Lead SOT-23	RJ-8	M91

 $^{1}$  Z = Pb-free part.

## NOTES

©2007 Analog Devices, Inc. All rights reserved. Trademarks and registered trademarks are the property of their respective owners. D06500-0-2/07(0)



www.analog.com

Rev. 0 | Page 12 of 12